


<b>Search Notes</b> 	<b>Application/Control No.</b> 10517886	<b>Applicant(s)/Patent Under Reexamination</b> YAZAWA ET AL.
	<b>Examiner</b> Deborah Yee	<b>Art Unit</b> 1793

SEARCHED			
Class	Subclass	Date	Examiner
148	325,326,608-610	11/11/08	/DY/
420	70	11/11/08	/DY/

SEARCH NOTES		
Search Notes	Date	Examiner
west and inventorship search	11/11/08	/DY/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
148	325,326,608,609,610	11/18/08	/DY/

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